


<b>Search Notes</b> 	<b>Application/Control No.</b> 10585276	<b>Applicant(s)/Patent Under Reexamination</b> WU, WENYAN
	<b>Examiner</b> CHRISTIAN L FRONDA	<b>Art Unit</b> 1652

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN search (HCAPLUS), STN search history attached to file	1/2/2010	CLF
WEST search (Patents & PGPub), WEST search history attached to file	1/2/2010	CLF
Inventor search in PALM	1/2/2010	CLF
STIC Search SEQ ID NOs:1-5	12/23/2009	CLF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/CHRISTIAN L FRONDA/ Primary Examiner.Art Unit 1652
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